

Appendix D

Contour Plots

CDMA835 (1013CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -31.1 dB A/m
Location: -10, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.4 dB
ABM1 comp = -1.70 dB A/m
BWC Factor = 0.151969 dB
Location: -10, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.70 dB A/m
BWC Factor = 0.151969 dB
Location: -10, -1.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.1 dB A/m
Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 46.6 dB
ABM1 comp = -2.47 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.47 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.98 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -36.8 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.4 dB

ABM1 comp = 5.64 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.64 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

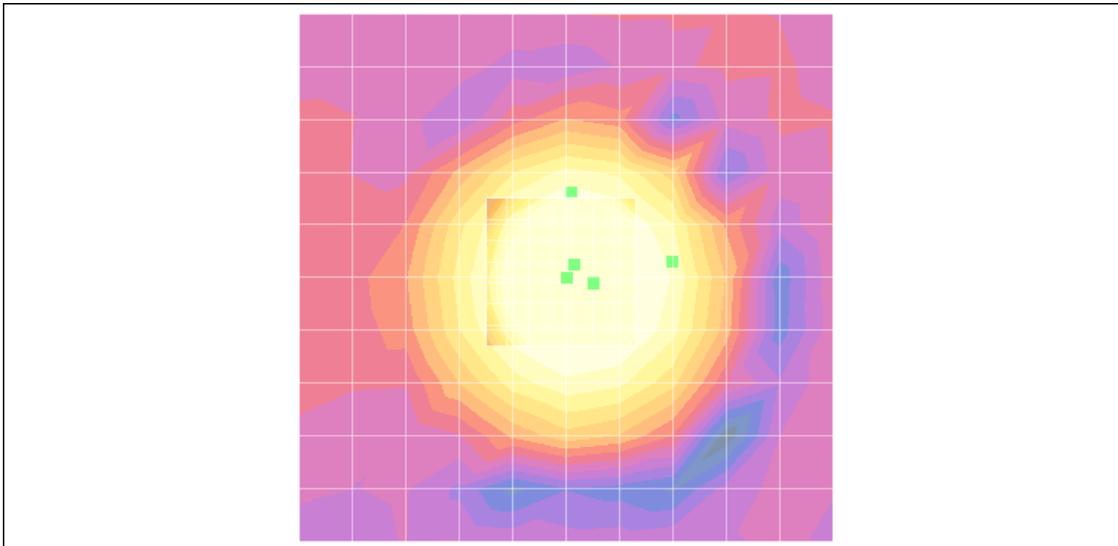
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.62 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (384CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -31.6 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 30.4 dB

ABM1 comp = -1.15 dB A/m

BWC Factor = 0.152993 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.15 dB A/m

BWC Factor = 0.152993 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.3 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 46.6 dB

ABM1 comp = -2.67 dB A/m

BWC Factor = 0.152993 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.67 dB A/m

BWC Factor = 0.152993 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.37 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -37.5 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 44.0 dB

ABM1 comp = 6.53 dB A/m

BWC Factor = 0.152993 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.53 dB A/m

BWC Factor = 0.152993 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

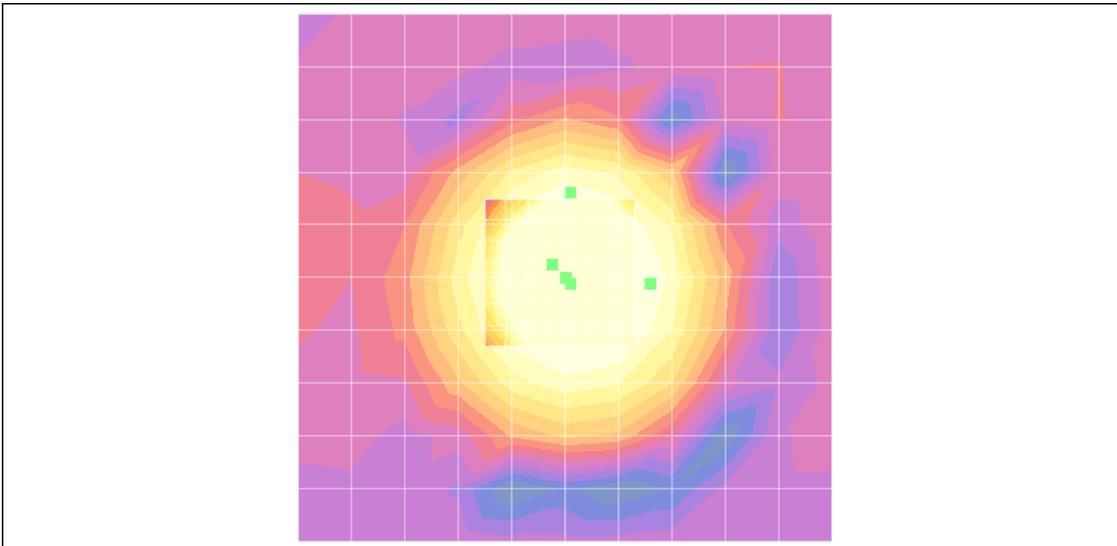
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.12 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (777CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -31.2 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.5 dB

ABM1 comp = -1.77 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.77 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -35.7 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 32.0 dB

ABM1 comp = -3.72 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.72 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.15 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -36.3 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.2 dB

ABM1 comp = 5.85 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.85 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

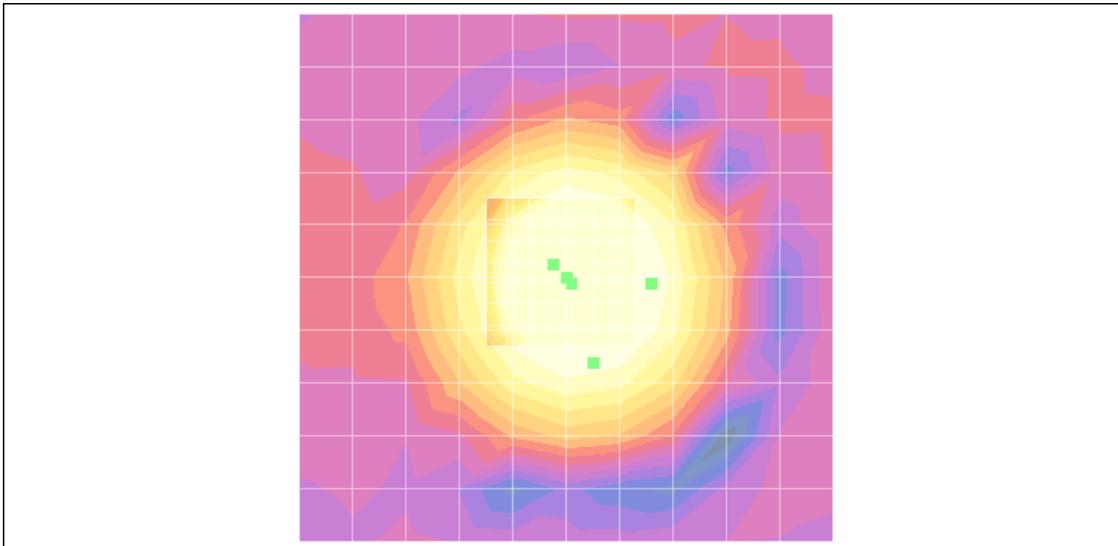
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.90 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (25CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: PCS 1900MHz FCC; Frequency: 1851.25 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -30.4 dB A/m
Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 28.8 dB
ABM1 comp = -1.62 dB A/m
BWC Factor = 0.151969 dB
Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.62 dB A/m
BWC Factor = 0.151969 dB
Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -35.6 dB A/m
Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 33.0 dB
ABM1 comp = -2.57 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.57 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.30 dB A/m
BWC Factor = 0.151969 dB
Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -37.1 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.6 dB

ABM1 comp = 5.53 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.53 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

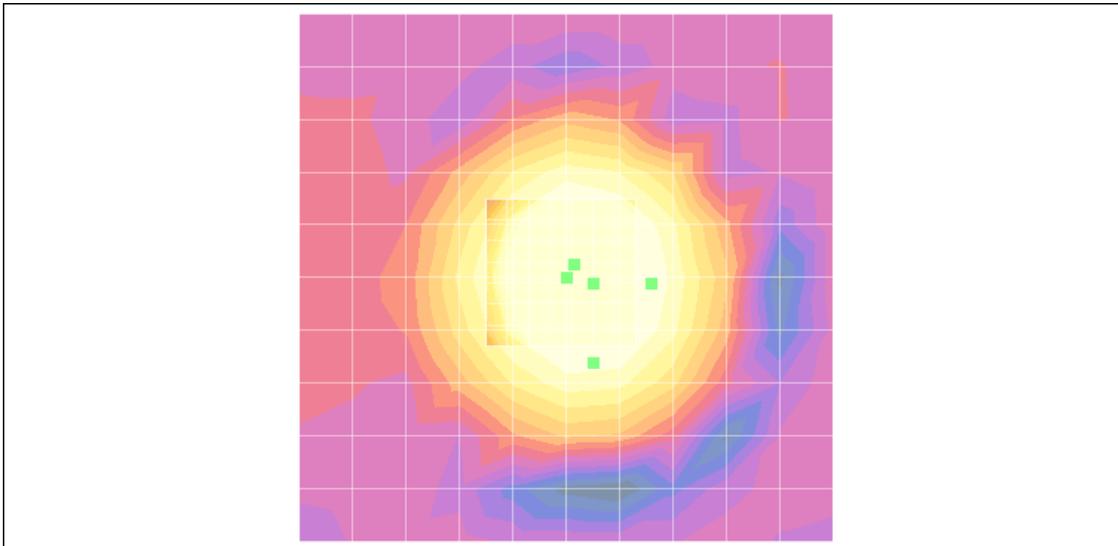
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.68 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (600CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: PCS 1900MHz FCC; Frequency: 1880 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.5 dB A/m
Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 47.8 dB
ABM1 comp = -1.66 dB A/m
BWC Factor = 0.151969 dB
Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.66 dB A/m
BWC Factor = 0.151969 dB
Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.7 dB A/m
Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 46.7 dB
ABM1 comp = -3.00 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.00 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.92 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.4 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 49.3 dB

ABM1 comp = 5.88 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.88 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

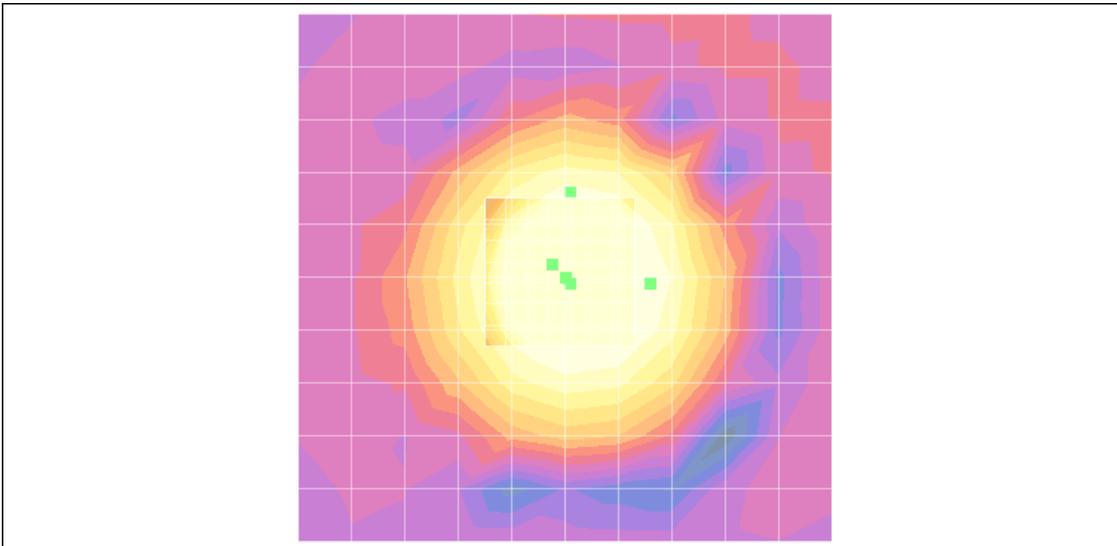
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.90 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (1175CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: PCS 1900MHz FCC; Frequency: 1908.75 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -31.2 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.8 dB

ABM1 comp = -1.36 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.36 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -36.4 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 33.9 dB

ABM1 comp = -2.47 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.47 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.30 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -1.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: 1.2, -3.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -35.9 dB A/m

Location: -0.5, -1.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.3 dB

ABM1 comp = 5.39 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -1.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.39 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -1.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

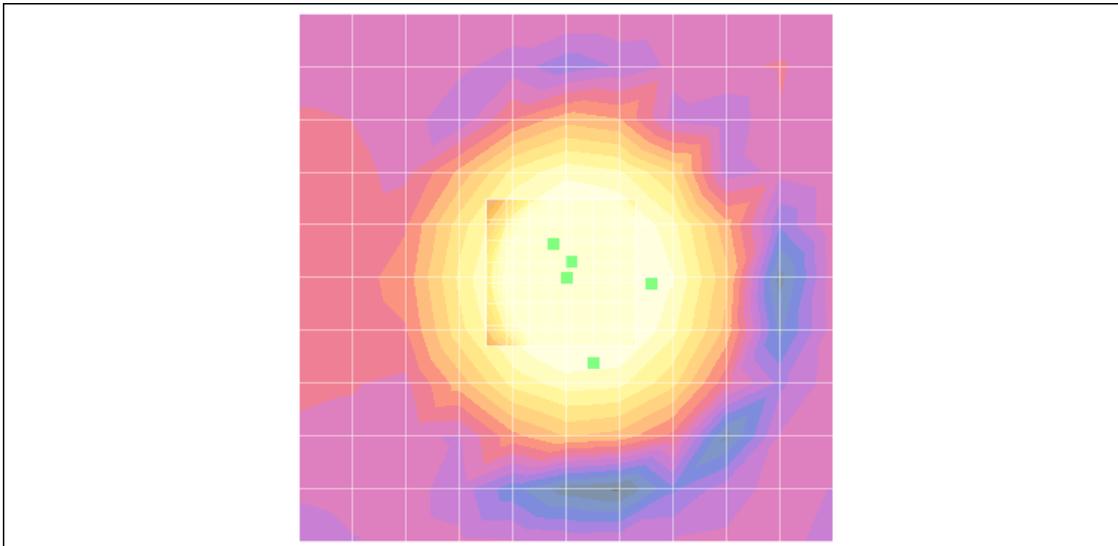
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.65 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM850 (128CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -16.1 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 25.2 dB

ABM1 comp = 9.09 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.09 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -21.5 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.3 dB

ABM1 comp = 7.82 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.82 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.152993 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.798 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -13.4 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 27.8 dB

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

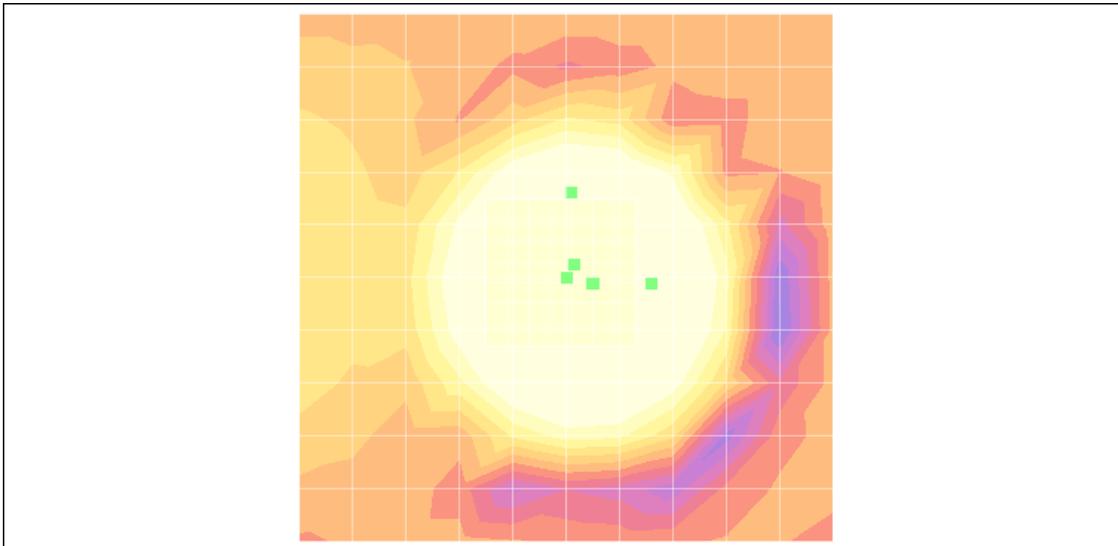
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.152993 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM850 (190CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -16.4 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 25.4 dB

ABM1 comp = 9.03 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.03 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -19.2 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 27.3 dB

ABM1 comp = 8.05 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 8.05 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.6 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.558 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -13.6 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 28.1 dB

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

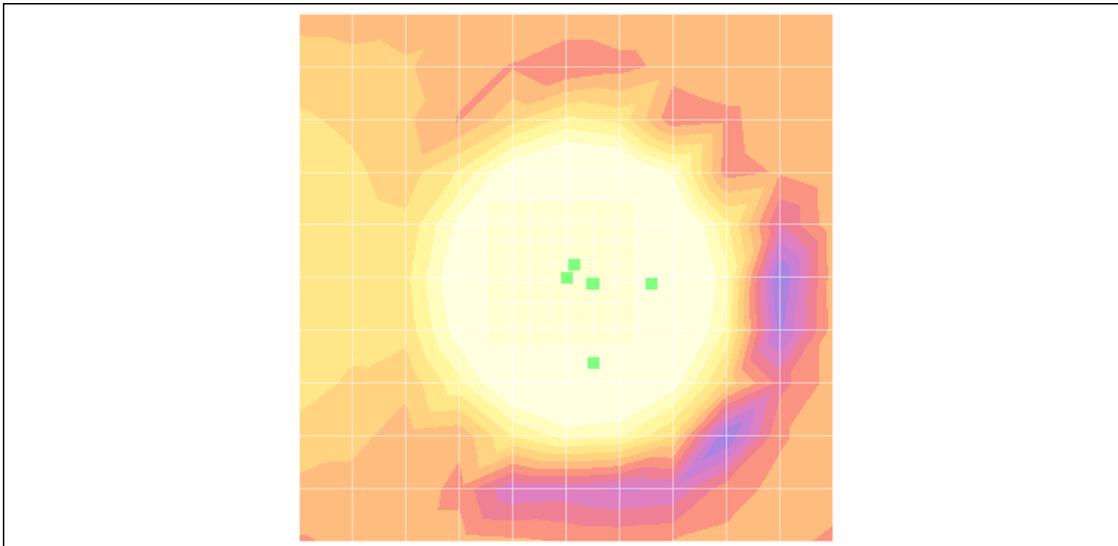
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.6 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM850 (251CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -16.5 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 25.8 dB

ABM1 comp = 9.21 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.21 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -19.8 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 27.9 dB

ABM1 comp = 8.10 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 8.10 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.736 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -13.9 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 28.4 dB

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

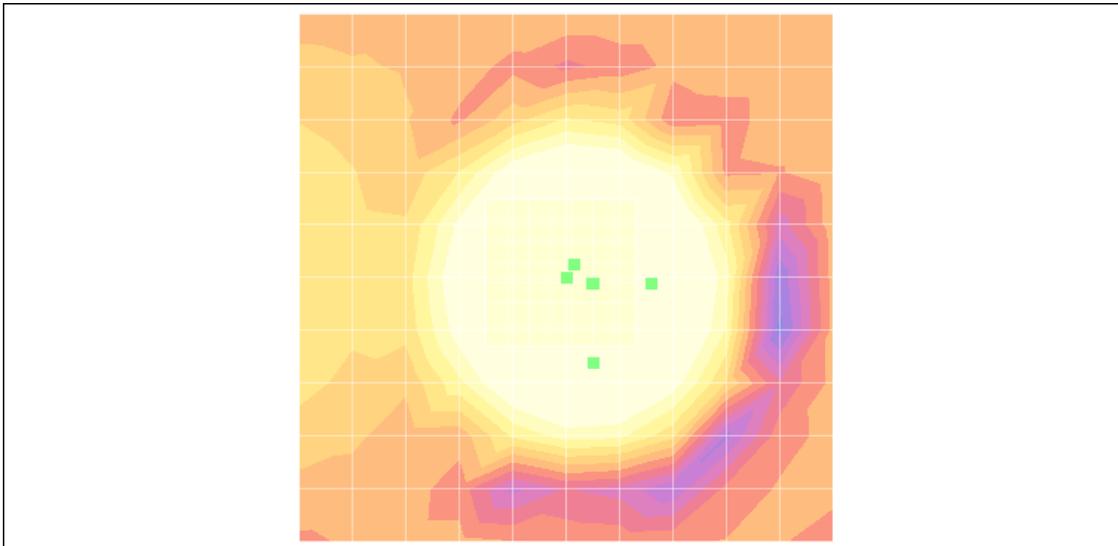
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.15103 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM1900 (512CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: GSM 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -19.8 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.1 dB

ABM1 comp = 9.23 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.23 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -23.3 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 31.4 dB

ABM1 comp = 8.10 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 8.10 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.905 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -16.6 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 31.2 dB

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

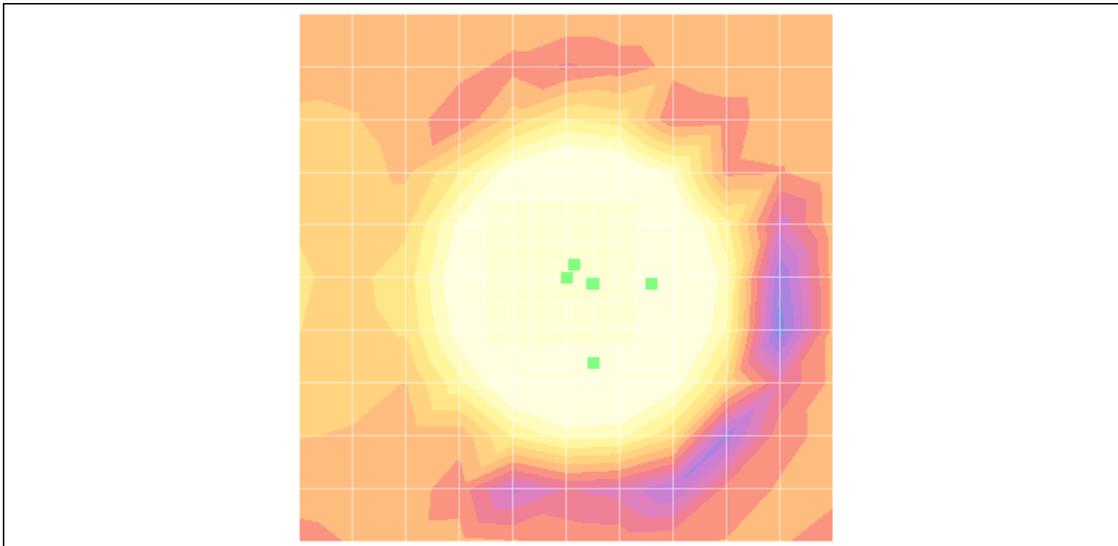
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM1900 (661CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: GSM 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -20.4 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.7 dB

ABM1 comp = 9.29 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.29 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -25.8 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 33.7 dB

ABM1 comp = 7.88 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.88 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.631 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -16.8 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 31.2 dB

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

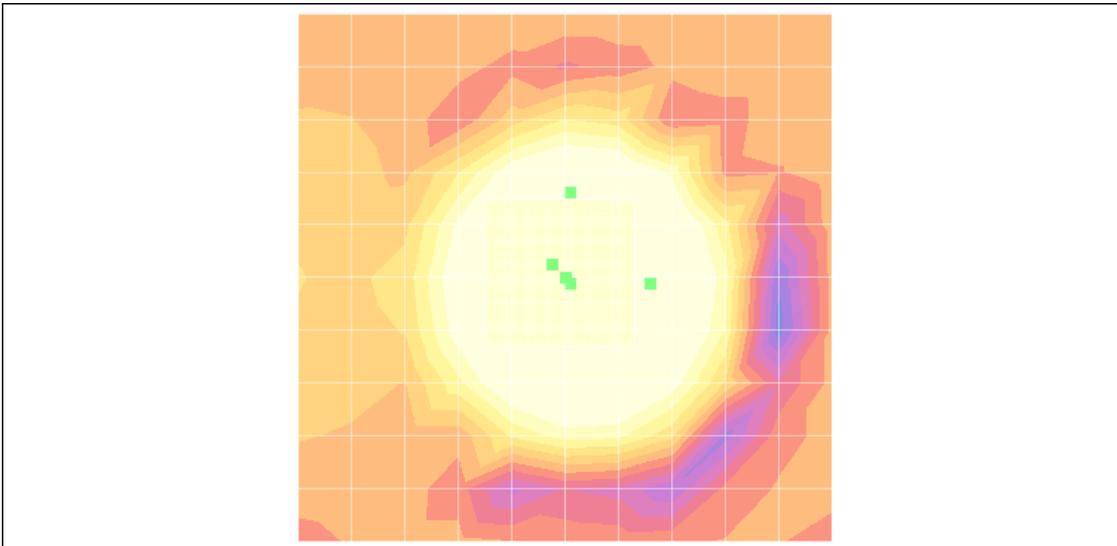
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM1900 (810CH) Slide down

DUT: TXT8045; Type: Slide

Communication System: GSM 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -20.6 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.9 dB

ABM1 comp = 9.33 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.33 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -26.2 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 34.2 dB

ABM1 comp = 7.96 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.96 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.152993 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.589 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -17.4 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 31.9 dB

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

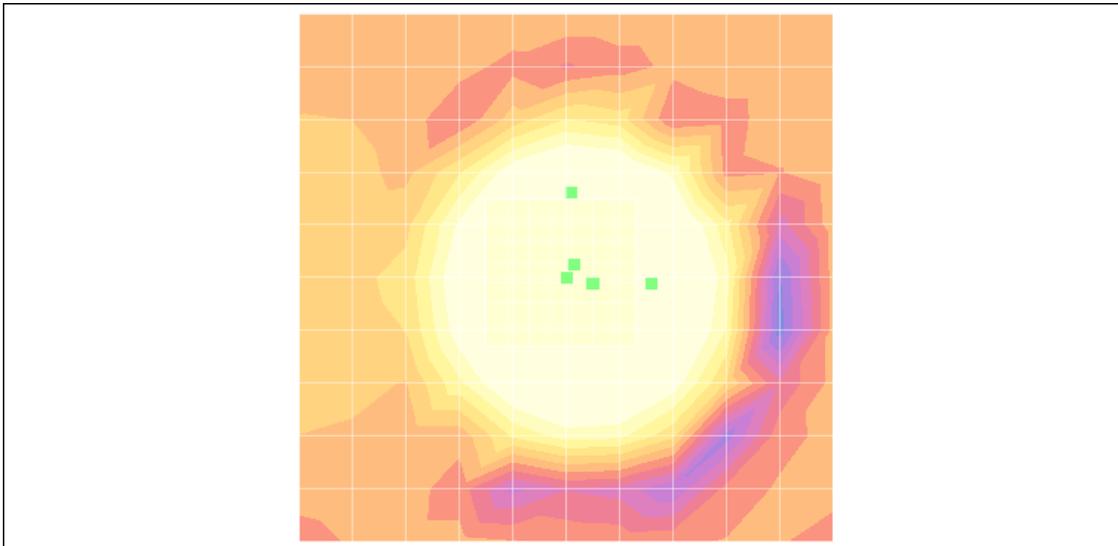
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.152993 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (1013CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.5 dB A/m

Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.9 dB

ABM1 comp = -1.69 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.69 dB A/m

BWC Factor = 0.151969 dB

Location: -10, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -48.6 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 46.5 dB

ABM1 comp = -2.10 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.10 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.71 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, -1.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: -0.8, -3.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -38.6 dB A/m

Location: -2.5, -1.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 44.3 dB

ABM1 comp = 5.71 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, -1.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.71 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, -1.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

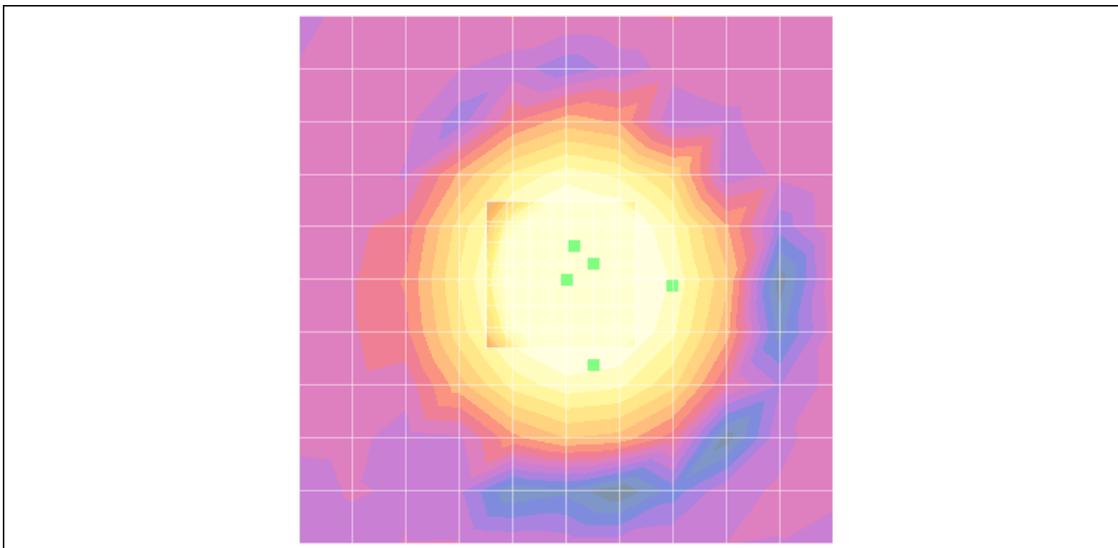
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.52 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (384CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.9 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.1 dB

ABM1 comp = -1.75 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.75 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -50.5 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 47.7 dB

ABM1 comp = -2.79 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.79 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.78 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.8 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 47.4 dB

ABM1 comp = 5.65 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.65 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

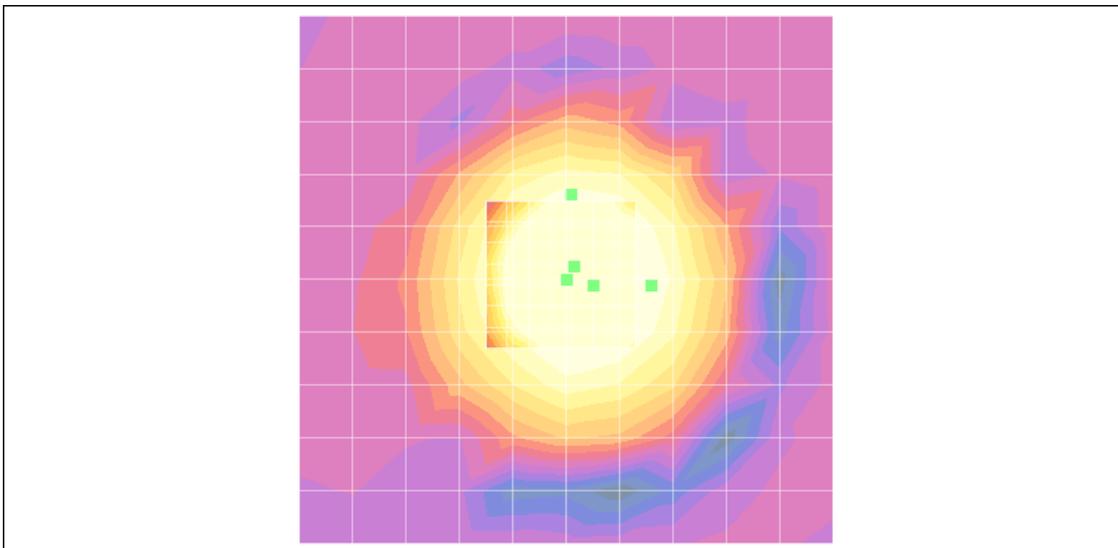
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.46 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (777CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Frequency: 848.31 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.1 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.3 dB

ABM1 comp = -1.88 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.88 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.0 dB A/m

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 46.0 dB

ABM1 comp = -2.92 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.92 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.21 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -42.1 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 47.4 dB

ABM1 comp = 5.36 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.36 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

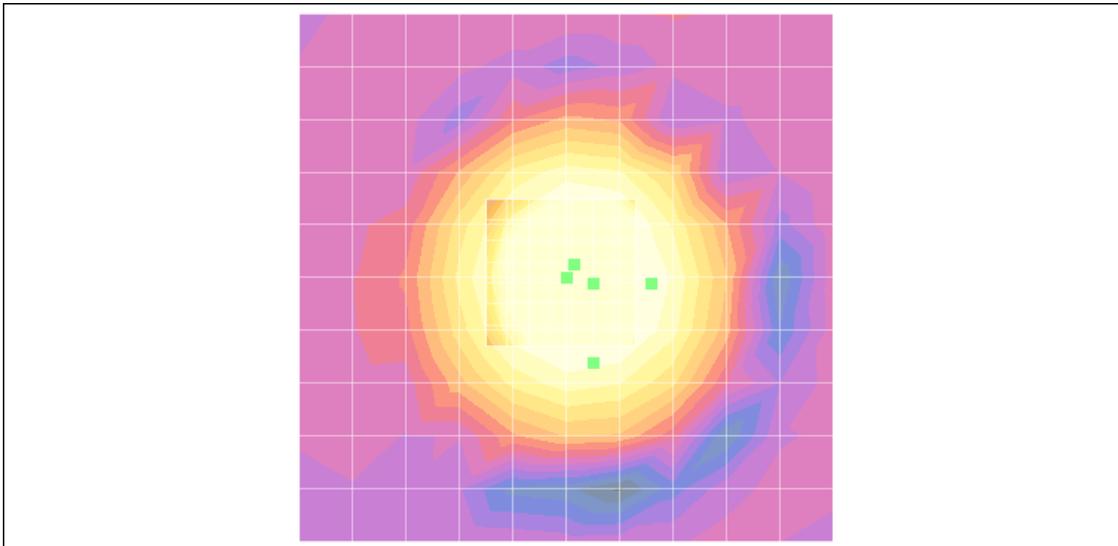
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.74 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (25CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: PCS 1900MHz FCC; Frequency: 1851.25 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.7 dB A/m
Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.1 dB
ABM1 comp = -1.54 dB A/m
BWC Factor = 0.151969 dB
Location: -10, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.54 dB A/m
BWC Factor = 0.151969 dB
Location: -10, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -50.5 dB A/m
Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 47.6 dB
ABM1 comp = -2.90 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.90 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.25 dB A/m
BWC Factor = 0.151969 dB
Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.0 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 47.1 dB

ABM1 comp = 6.07 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.07 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

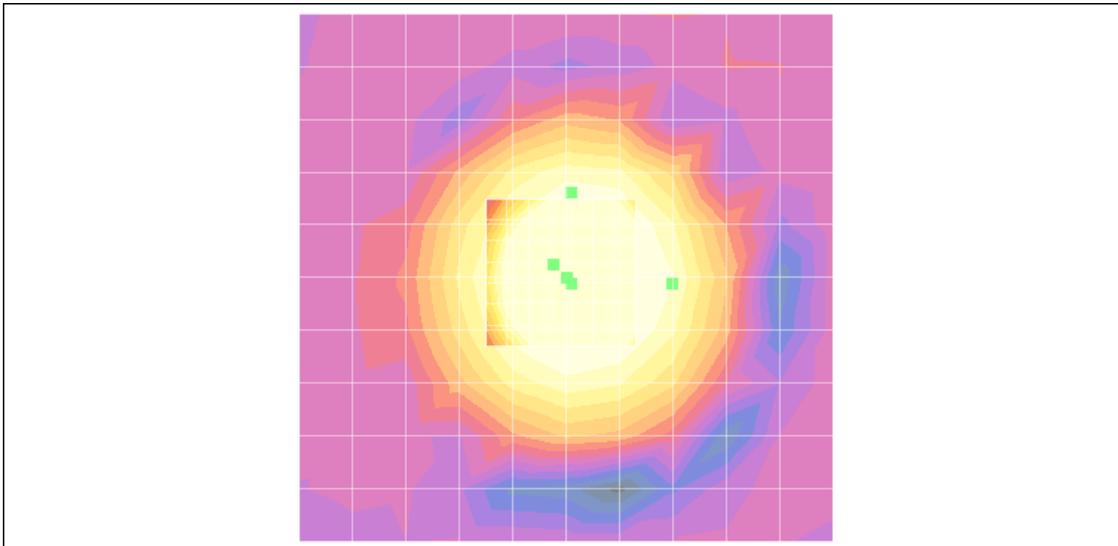
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.18 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (600CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: PCS 1900MHz FCC; Frequency: 1880 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.1 dB A/m

Location: -8, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 41.1 dB

ABM1 comp = -1.96 dB A/m

BWC Factor = 0.151969 dB

Location: -8, -1.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.96 dB A/m

BWC Factor = 0.151969 dB

Location: -8, -1.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -49.0 dB A/m

Location: -0.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 45.7 dB

ABM1 comp = -3.29 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.29 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.11 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.9 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 48.0 dB

ABM1 comp = 6.06 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.06 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

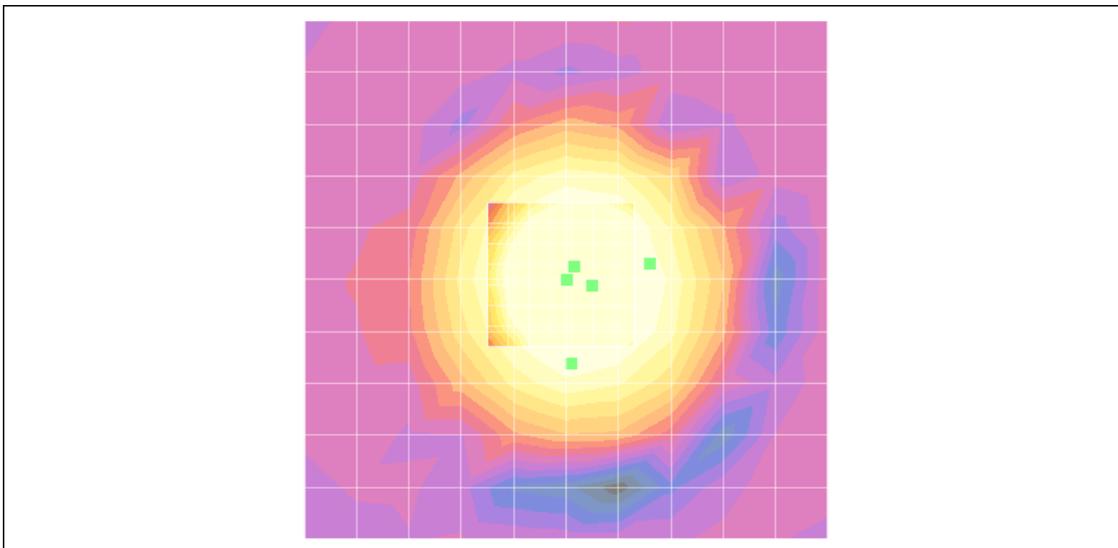
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.83 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

PCS1900 (1175CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: PCS 1900MHz FCC; Frequency: 1908.75 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -43.7 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.3 dB

ABM1 comp = -1.36 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -1.36 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -46.8 dB A/m

Location: -0.5, 10, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 44.2 dB

ABM1 comp = -2.69 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 10, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.69 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 10, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.24 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 2.00 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -42.0 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 48.5 dB

ABM1 comp = 6.41 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.41 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

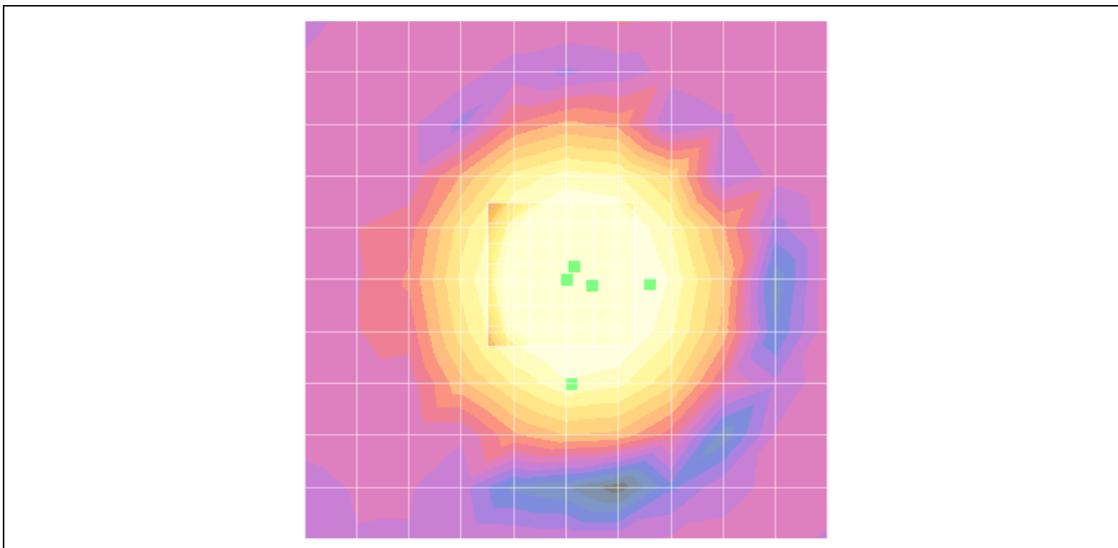
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 4.51 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM850 (128CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -20.8 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.8 dB

ABM1 comp = 9.06 dB A/m

BWC Factor = 0.152993 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.06 dB A/m

BWC Factor = 0.152993 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -23.1 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 30.9 dB

ABM1 comp = 7.71 dB A/m

BWC Factor = 0.152993 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.71 dB A/m

BWC Factor = 0.152993 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.06 dB
BWC Factor = 10.8 dB
Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -14.7 dB A/m
Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.0 dB
ABM1 comp = 14.3 dB A/m
BWC Factor = 0.152993 dB
Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

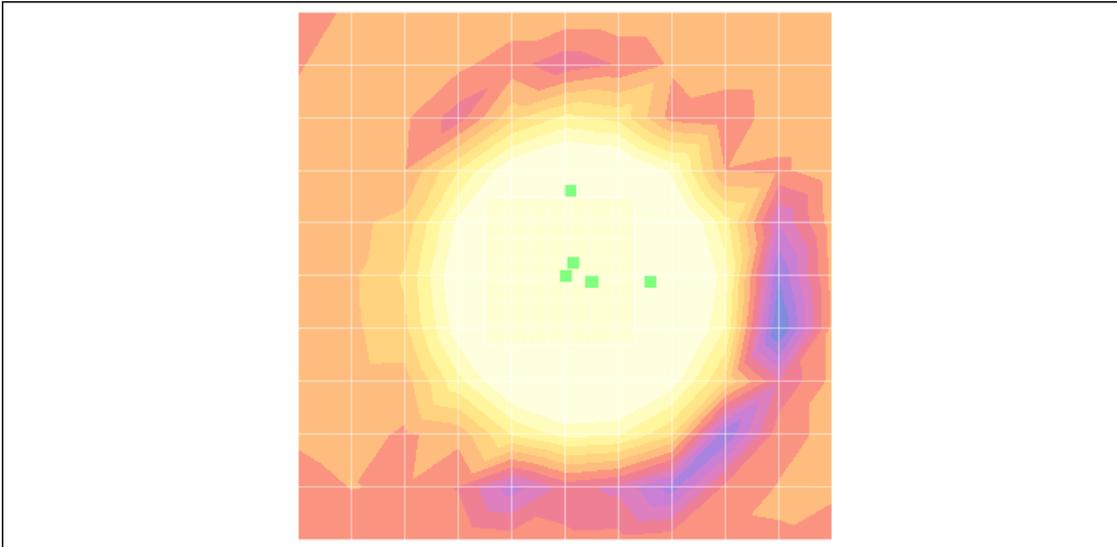
ABM1 comp = 14.3 dB A/m
BWC Factor = 0.152993 dB
Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m
BWC Factor = 0.15103 dB
Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM850 (190CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -21.9 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 30.1 dB

ABM1 comp = 8.21 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 8.21 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -24.0 dB A/m

Location: -0.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 31.2 dB

ABM1 comp = 7.22 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.22 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.902 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -14.6 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 29.1 dB

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.5 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

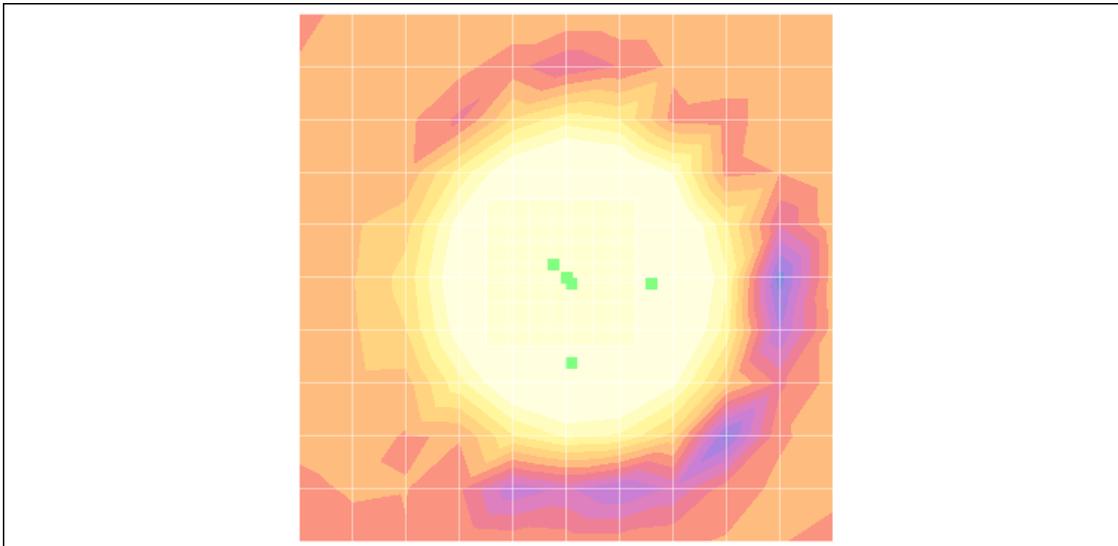
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.4 dB A/m

BWC Factor = 0.15103 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM850 (251CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -17.8 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 26.8 dB

ABM1 comp = 8.93 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 8.93 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -29.1 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 36.9 dB

ABM1 comp = 7.77 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.77 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.7 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.931 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -19.3 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 34.0 dB

ABM1 comp = 14.7 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.7 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

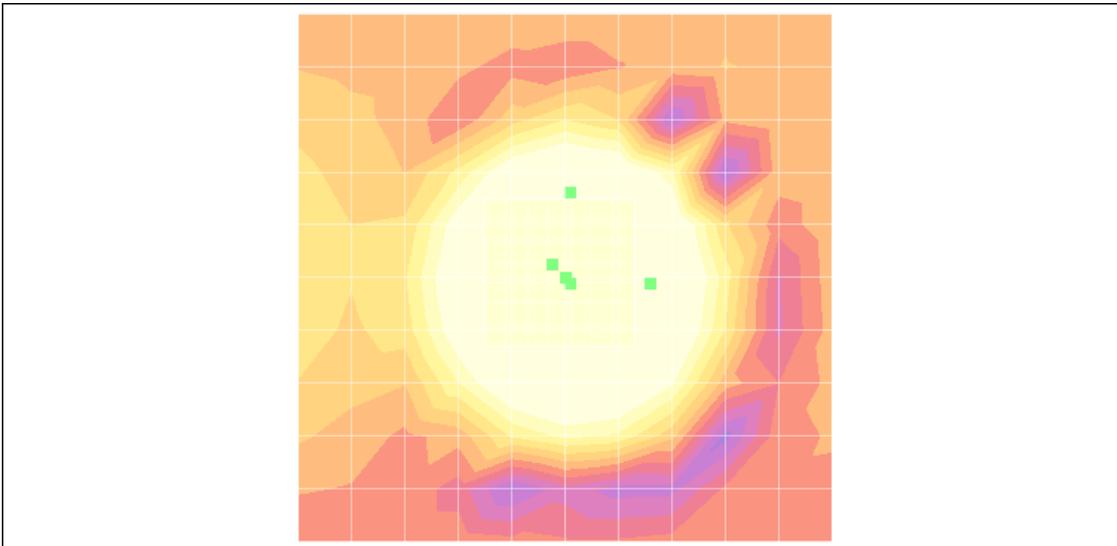
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.7 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM1900 (512CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: GSM 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -23.7 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 32.7 dB

ABM1 comp = 8.98 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 8.98 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -26.1 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 33.8 dB

ABM1 comp = 7.65 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.65 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.152993 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.995 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -17.6 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 31.9 dB

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.151969 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

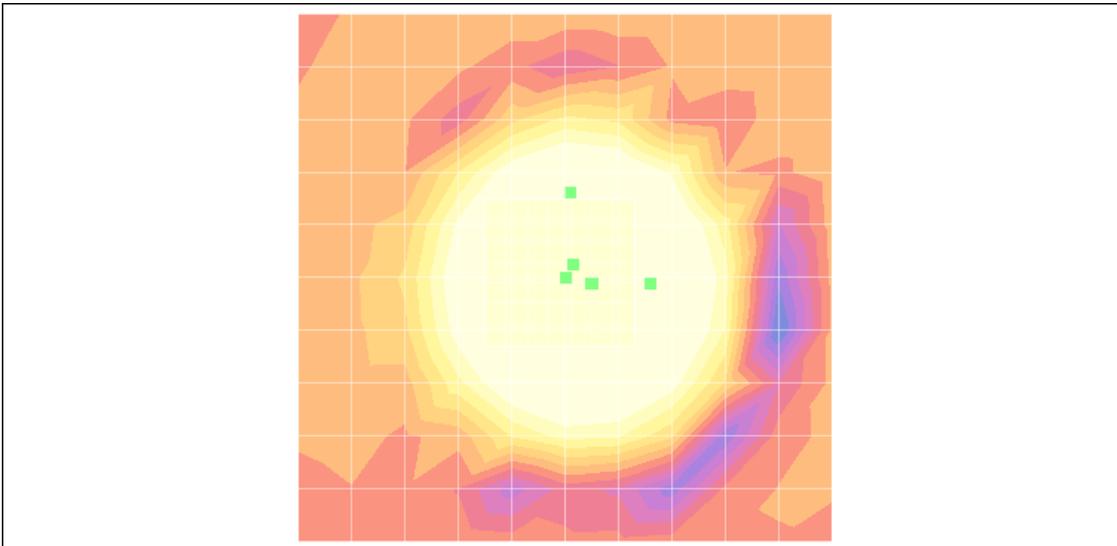
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.1 dB A/m

BWC Factor = 0.152993 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM1900 (661CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: GSM 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -24.9 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 33.9 dB

ABM1 comp = 9.08 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.08 dB A/m

BWC Factor = 0.151969 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -26.3 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 34.0 dB

ABM1 comp = 7.72 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.72 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.827 dB

BWC Factor = 10.8 dB

Location: 1.2, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -17.9 dB A/m

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 32.2 dB

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

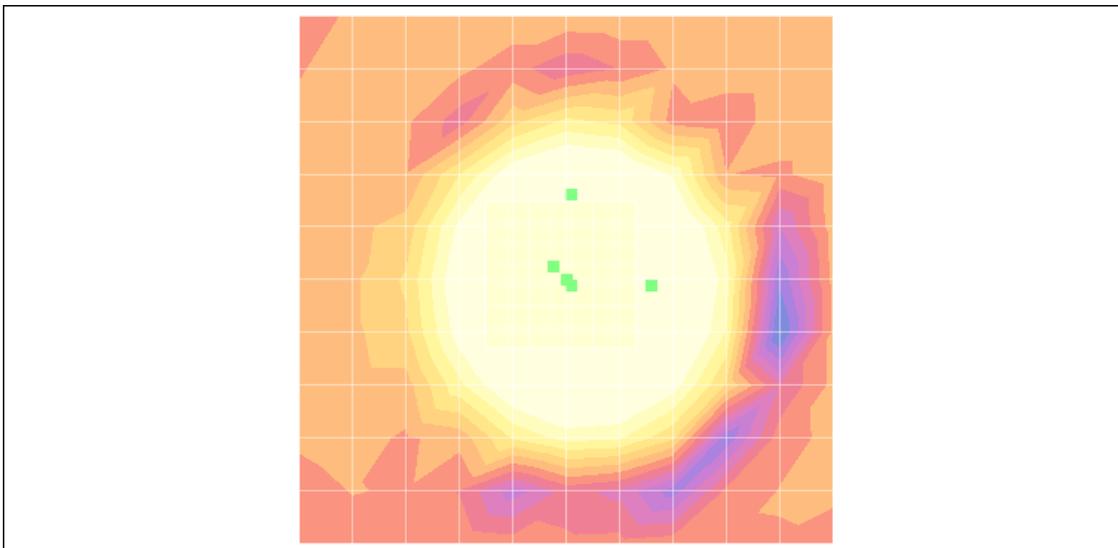
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.1 dB A/m

BWC Factor = 0.15103 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

GSM1900 (810CH) Slide up

DUT: TXT8045; Type: Slide

Communication System: GSM 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: AMB with Coil Section ; Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -25.0 dB A/m

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 34.1 dB

ABM1 comp = 9.05 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 9.05 dB A/m

BWC Factor = 0.15103 dB

Location: -8, 0.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -26.6 dB A/m

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 34.4 dB

ABM1 comp = 7.71 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, -8, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 7.71 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, -8, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.2 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.883 dB

BWC Factor = 10.8 dB

Location: -0.8, -1.2, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -18.1 dB A/m

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 32.4 dB

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.15103 dB

Location: -2.5, 0.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

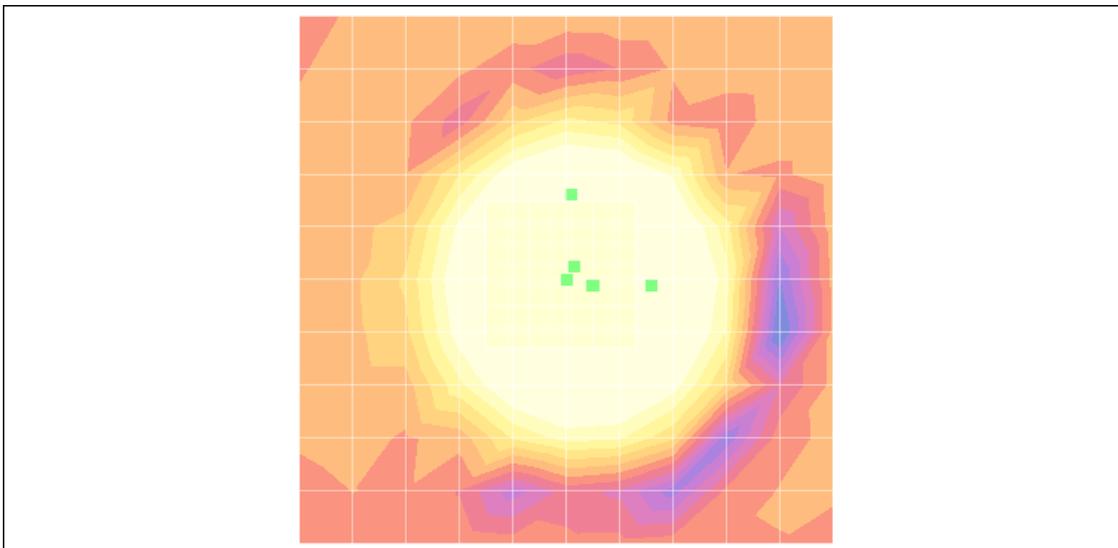
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 14.3 dB A/m

BWC Factor = 0.15103 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m